

Notice of References Cited	Application/Control No. 10/729,006		Applicant(s)/Patent Under Reexamination TOYOMURA, FUMITAKA	
	Examiner Asha.Hall		Art Unit 1753	Page 1 of 1

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	U	Jackson et al., Handbook of Semiconductors Technology, Vol. 2., Wiley, Copyright 2000, p.348.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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